

International  
**IR** Rectifier  
 HEXFET® Power MOSFET

PD - 91354A

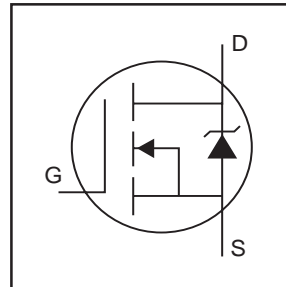
**IRFZ24N**

- Advanced Process Technology
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

**Description**

Fifth Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

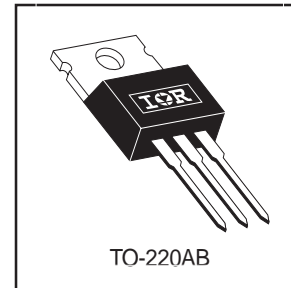
The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



$$V_{DS} = 55V$$

$$R_{DS(on)} = 0.07\Omega$$

$$I_D = 17A$$



**Absolute Maximum Ratings**

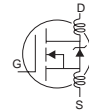
|                             | Parameter                                | Max.                  | Units |
|-----------------------------|------------------------------------------|-----------------------|-------|
| $I_D$ @ $T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS}$ @ 10V | 17                    | A     |
| $I_D$ @ $T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS}$ @ 10V | 12                    |       |
| $I_{DM}$                    | Pulsed Drain Current ①                   | 68                    |       |
| $P_D$ @ $T_C = 25^\circ C$  | Power Dissipation                        | 45                    | W     |
|                             | Linear Derating Factor                   | 0.30                  | W/°C  |
| $V_{GS}$                    | Gate-to-Source Voltage                   | ±20                   | V     |
| $E_{AS}$                    | Single Pulse Avalanche Energy ②          | 71                    | mJ    |
| $I_{AR}$                    | Avalanche Current ①                      | 10                    | A     |
| $E_{AR}$                    | Repetitive Avalanche Energy ①            | 4.5                   | mJ    |
| dv/dt                       | Peak Diode Recovery dv/dt ③              | 5.0                   | V/ns  |
| $T_J$                       | Operating Junction and                   | -55 to + 175          | °C    |
| $T_{STG}$                   | Storage Temperature Range                |                       |       |
|                             | Soldering Temperature, for 10 seconds    | 300 (1.6mm from case) |       |
|                             | Mounting torque, 6-32 or M3 screw.       | 10 lbf•in (1.1N•m)    |       |

**Thermal Resistance**

|                 | Parameter                           | Min. | Typ. | Max. | Units |
|-----------------|-------------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | —    | 3.3  | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | —    | 0.50 | —    |       |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | —    | 62   |       |

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

|                                 | Parameter                            | Min. | Typ.  | Max. | Units               | Conditions                                                                  |
|---------------------------------|--------------------------------------|------|-------|------|---------------------|-----------------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 55   | —     | —    | V                   | $V_{GS} = 0V, I_D = 250\mu A$                                               |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.052 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$                        |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —     | 0.07 | $\Omega$            | $V_{GS} = 10V, I_D = 10A$ ④                                                 |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                                           |
| $g_{fs}$                        | Forward Transconductance             | 4.5  | —     | —    | S                   | $V_{DS} = 25V, I_D = 10A$                                                   |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 25   | $\mu A$             | $V_{DS} = 55V, V_{GS} = 0V$                                                 |
|                                 |                                      | —    | —     | 250  |                     | $V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$                        |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 100  | nA                  | $V_{GS} = 20V$                                                              |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -100 |                     | $V_{GS} = -20V$                                                             |
| $Q_g$                           | Total Gate Charge                    | —    | —     | 20   | nC                  | $I_D = 10A$                                                                 |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —     | 5.3  |                     | $V_{DS} = 44V$                                                              |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —     | 7.6  |                     | $V_{GS} = 10V$ , See Fig. 6 and 13 ④                                        |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 4.9   | —    | ns                  | $V_{DD} = 28V$                                                              |
| $t_r$                           | Rise Time                            | —    | 34    | —    |                     | $I_D = 10A$                                                                 |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 19    | —    |                     | $R_G = 24\Omega$                                                            |
| $t_f$                           | Fall Time                            | —    | 27    | —    |                     | $R_D = 2.6\Omega$ , See Fig. 10 ④                                           |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5   | —    | nH                  | Between lead,<br>6mm (0.25in.)<br>from package<br>and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5   | —    |                     |                                                                             |
| $C_{iss}$                       | Input Capacitance                    | —    | 370   | —    | pF                  | $V_{GS} = 0V$                                                               |
| $C_{oss}$                       | Output Capacitance                   | —    | 140   | —    |                     | $V_{DS} = 25V$                                                              |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 65    | —    |                     | $f = 1.0\text{MHz}$ , See Fig. 5                                            |



## Source-Drain Ratings and Characteristics

|          | Parameter                                 | Min. | Typ. | Max. | Units | Conditions                                                              |
|----------|-------------------------------------------|------|------|------|-------|-------------------------------------------------------------------------|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —    | —    | 17   | A     | MOSFET symbol<br>showing the<br>integral reverse<br>p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —    | —    | 68   |       |                                                                         |
| $V_{SD}$ | Diode Forward Voltage                     | —    | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 10A, V_{GS} = 0V$ ④                      |
| $t_{rr}$ | Reverse Recovery Time                     | —    | 56   | 83   | ns    | $T_J = 25^\circ\text{C}, I_F = 10A$                                     |
| $Q_{rr}$ | Reverse Recovery Charge                   | —    | 120  | 180  | nC    | $di/dt = 100A/\mu s$ ④                                                  |

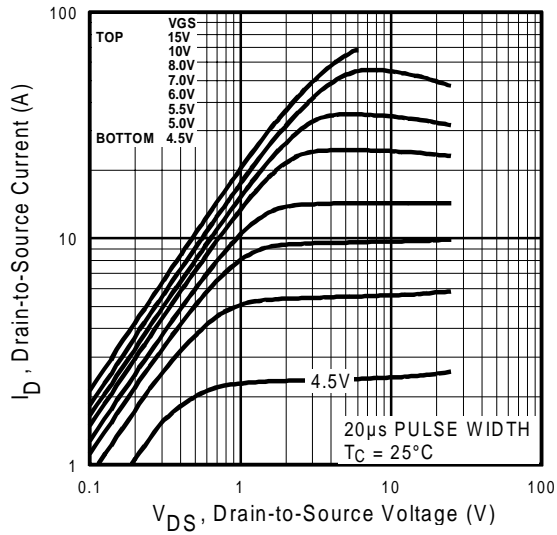
### Notes:

① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )

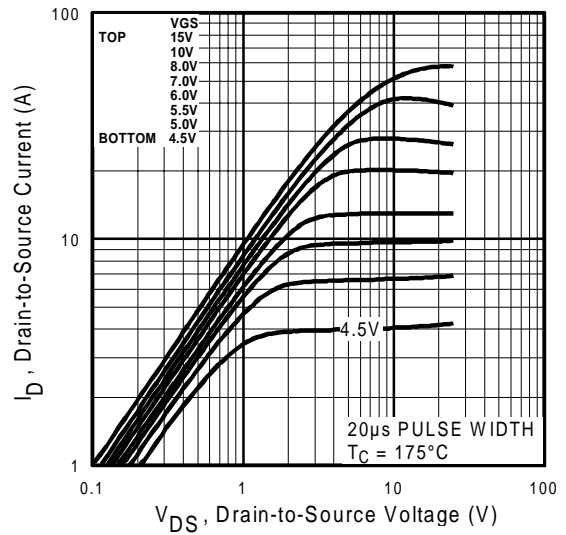
③  $I_{SD} \leq 10A, di/dt \leq 280A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175^\circ\text{C}$

②  $V_{DD} = 25V$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 1.0\text{mH}$   
 $R_G = 25\Omega, I_{AS} = 10A$ . (See Figure 12)

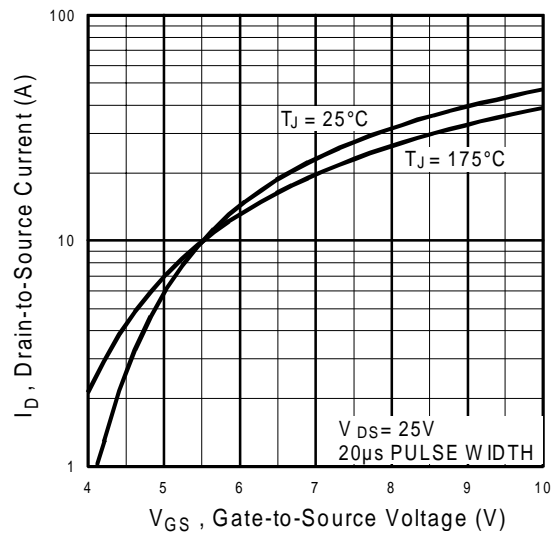
④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



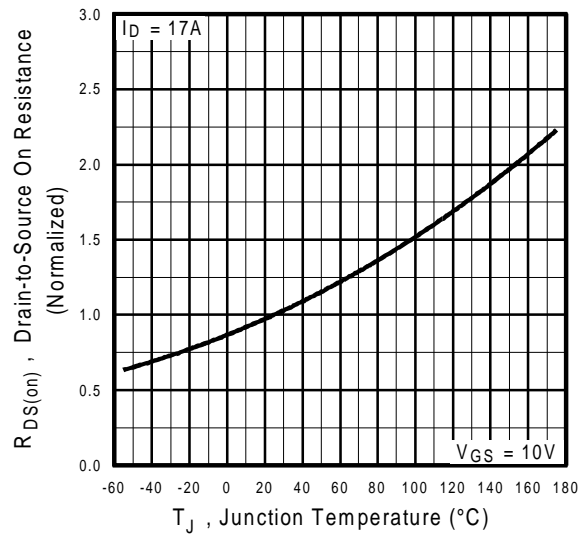
**Fig 1.** Typical Output Characteristics,  
 $T_J = 25^\circ\text{C}$



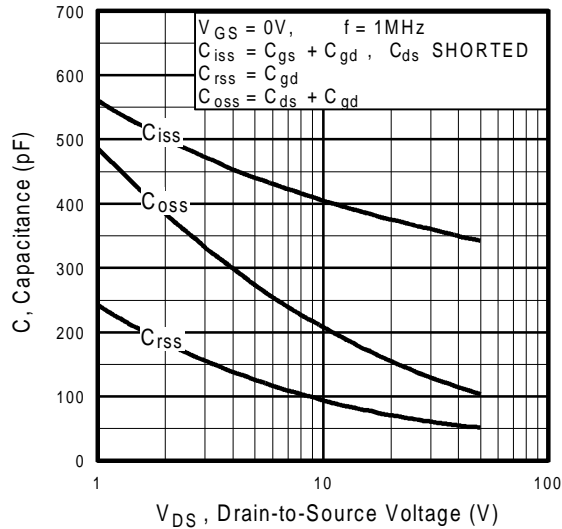
**Fig 2.** Typical Output Characteristics,  
 $T_J = 175^\circ\text{C}$



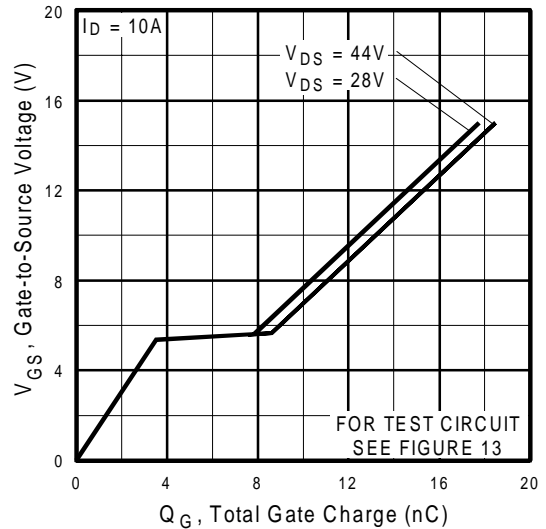
**Fig 3.** Typical Transfer Characteristics



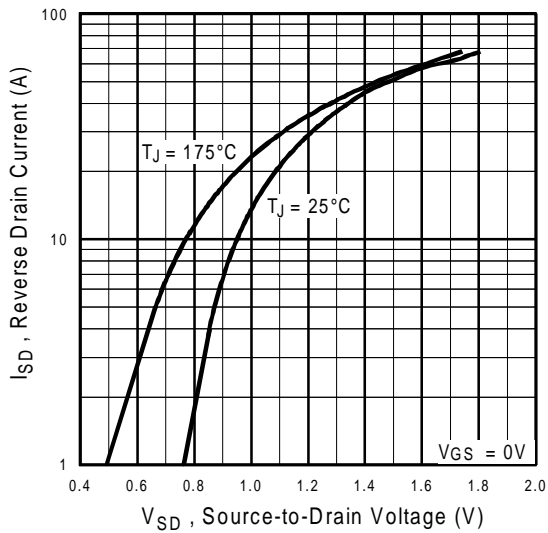
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



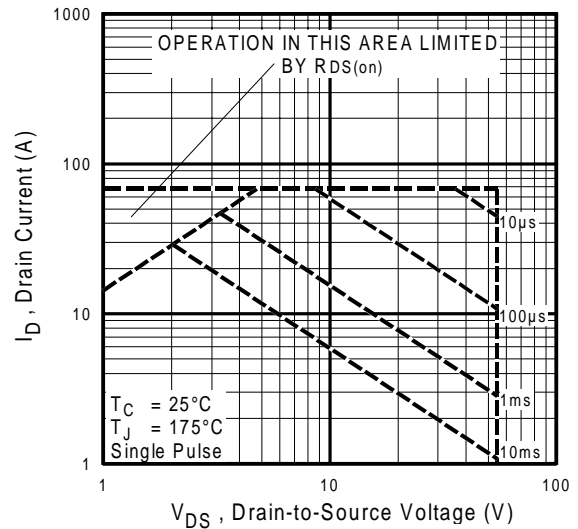
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



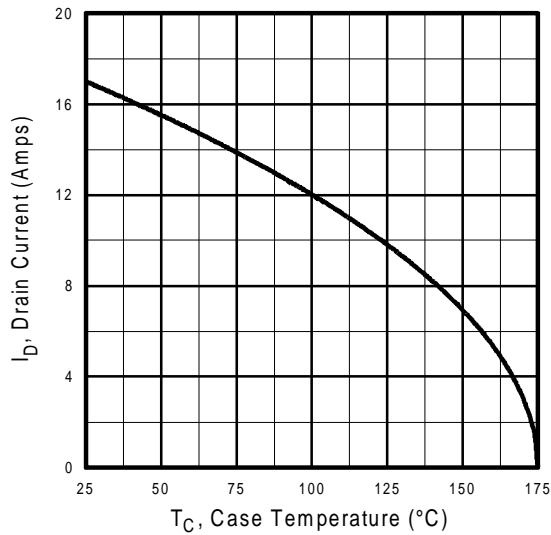
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



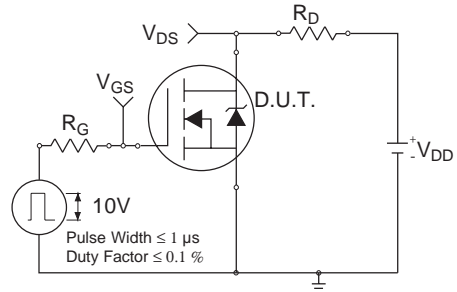
**Fig 7.** Typical Source-Drain Diode Forward Voltage



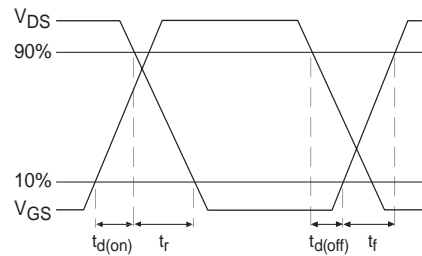
**Fig 8.** Maximum Safe Operating Area



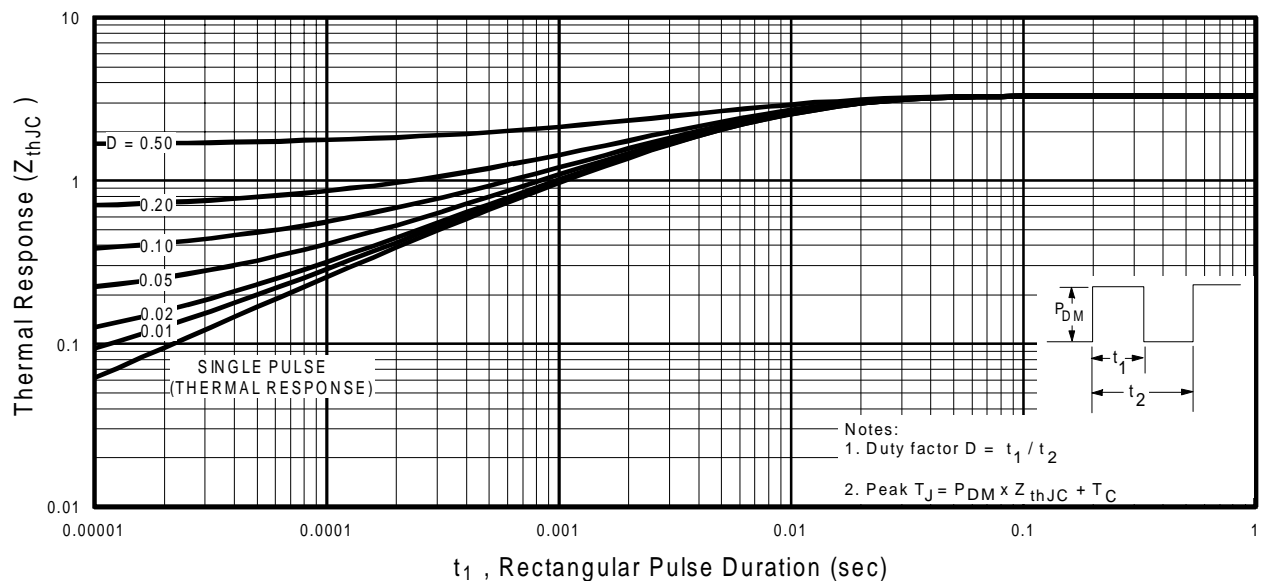
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit



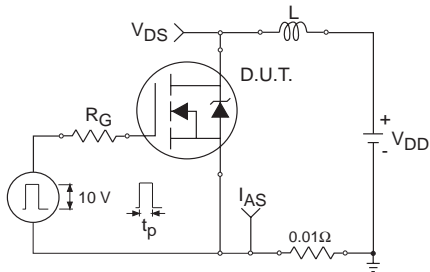
**Fig 10b.** Switching Time Waveforms



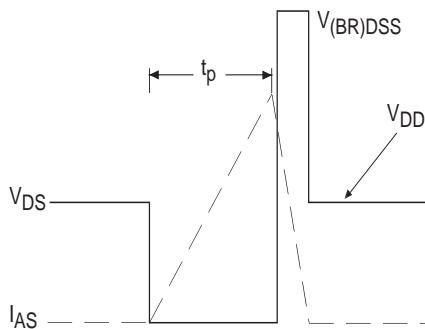
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFZ24N

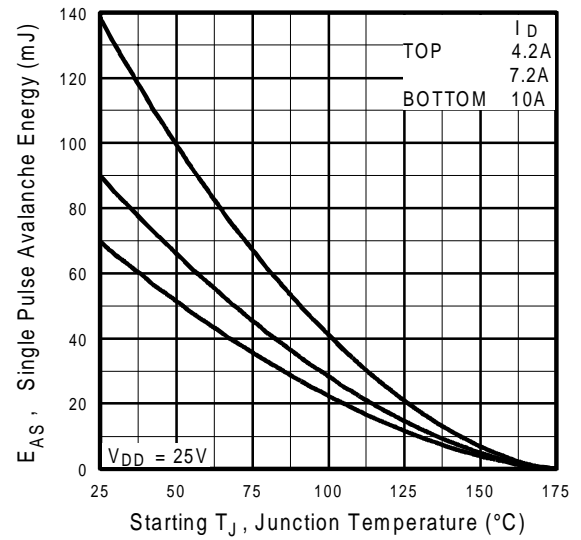
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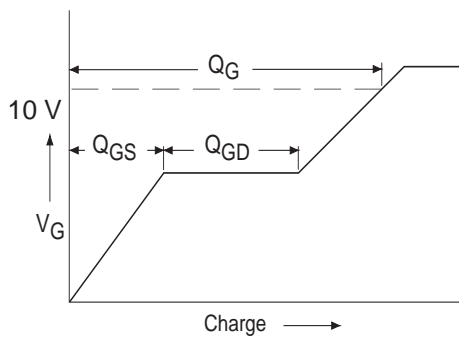
**Fig 12a.** Unclamped Inductive Test Circuit



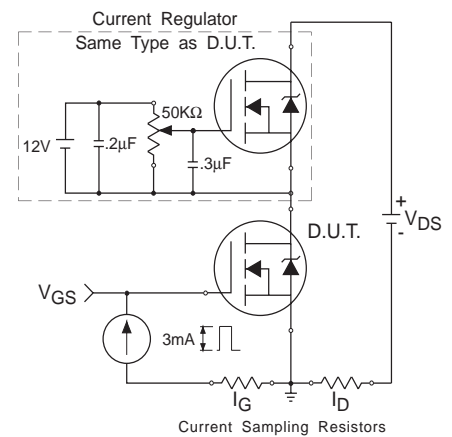
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13a.** Basic Gate Charge Waveform



**Fig 13b.** Gate Charge Test Circuit

**Circuit Layout Considerations**

- Low Stray Inductance
- Ground Plane
- Low Leakage Inductance

**Current Transformer**

- $dv/dt$  controlled by  $R_G$
- Driver same type as D.U.T.
- $I_{SD}$  controlled by Duty Factor "D"
- D.U.T. - Device Under Test



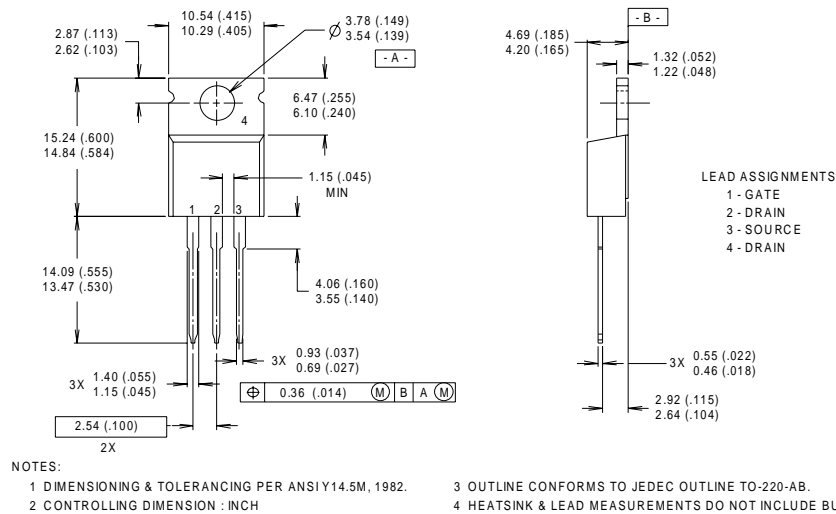
# IRFZ24N

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## Package Outline

### TO-220AB

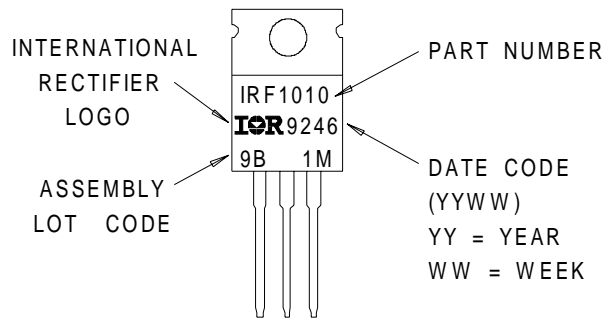
Dimensions are shown in millimeters (inches)



## Part Marking Information

### TO-220AB

EXAMPLE : THIS IS AN IRF1010  
 WITH ASSEMBLY  
 LOT CODE 9B1M



International  
**IR** Rectifier

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**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

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